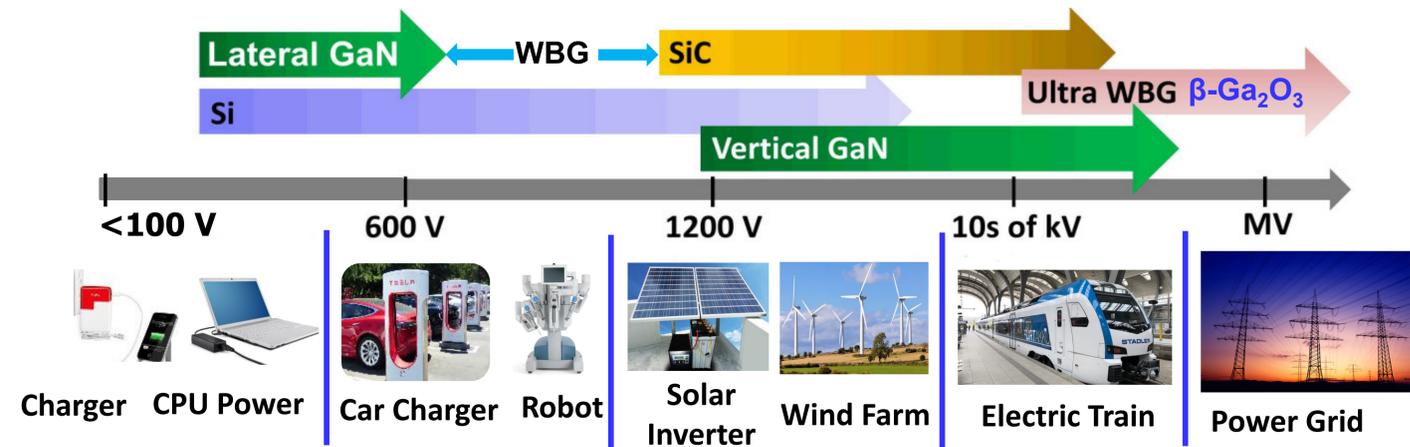


Wide Bandgap (WBG) in High-Power Electronics

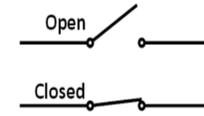


R. Kaplar, Sandia National Labs, UNM ECE Graduate Seminar, 2019

S. Pearton et al., *J. Appl. Phys.* 124, 220901 (2018)

WBG in Energy-Efficient Switching

High breakdown voltage (V_B) (off-state)



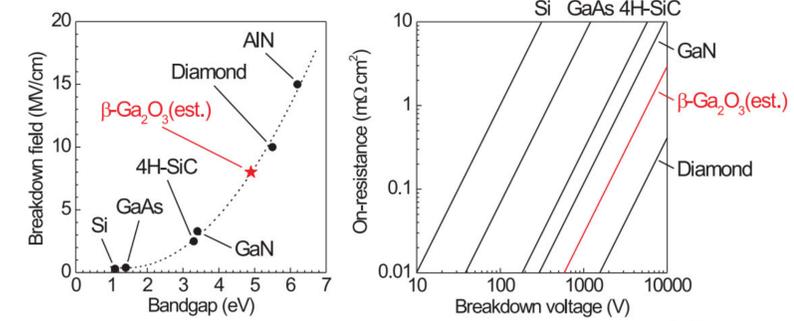
Low on-resistance R_{on} (on-state)

Towards Green Electronics \rightarrow Low loss \rightarrow High-Power \rightarrow Smaller

Breakdown Voltage

$$V_B = 0.5 \times E_{max} \times W$$

Max field Width



Si ~ 0.3 MV/cm

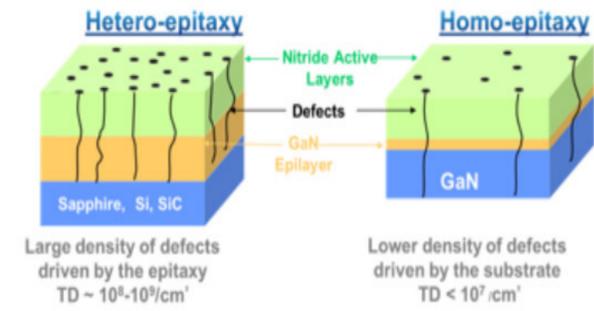
GaN 3.4 MV/cm

$\beta\text{-Ga}_2\text{O}_3$ 4.8 MV/cm

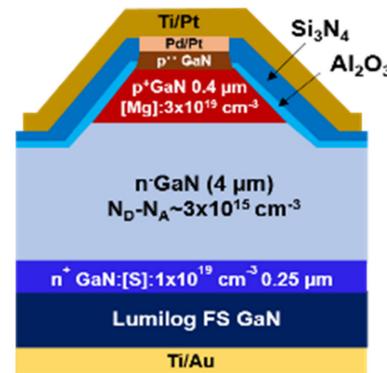
M. Higashiwakiet al., *Appl. Phys. Lett.* 100, 013504 (2012)

High-power GaN-on-GaN Device from Molecular Beam Epitaxy (MBE)

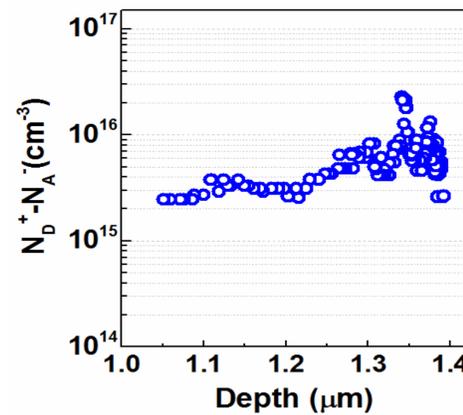
Low dislocation density from GaN-on-GaN growth



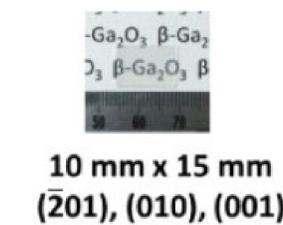
GaN-on-GaN p-n Diode



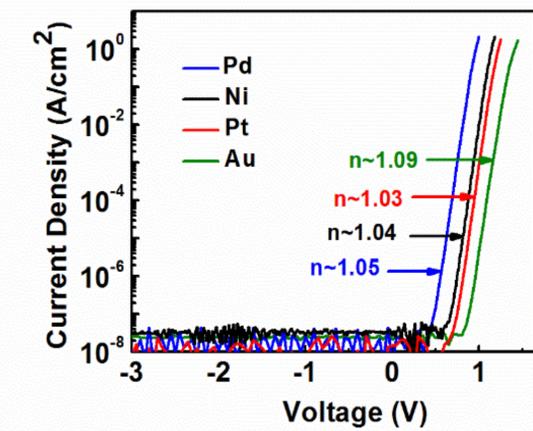
Low unintentional doping from NH_3 -MBE



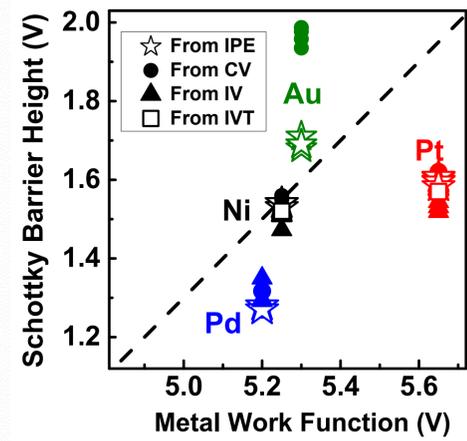
High-power Homoepitaxy $\beta\text{-Ga}_2\text{O}_3$ Devices



10 mm x 15 mm (201), (010), (001)



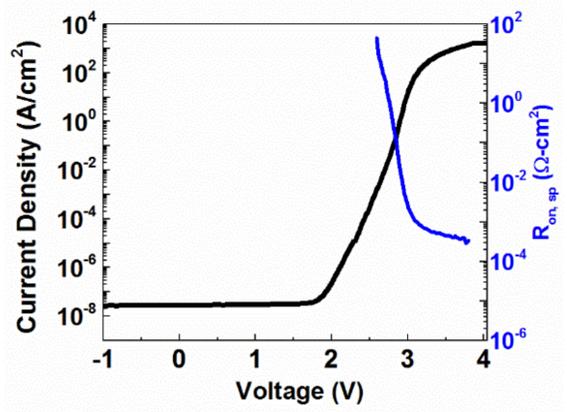
High-quality Schottky diode with unity ideality factor



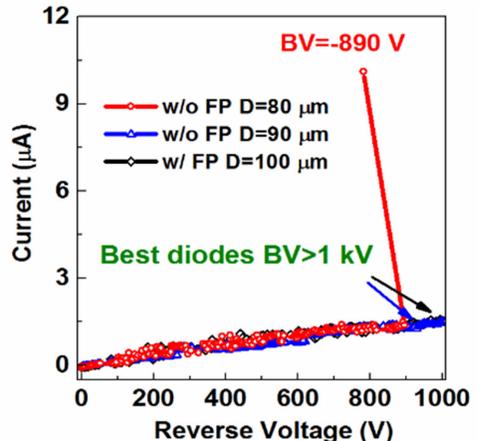
Schottky barrier height can be modulated with metal choice: Not pinned interface

E. Farzana et al., *Appl. Phys. Lett.*, 110, 202102 (2017). Editor's Pick

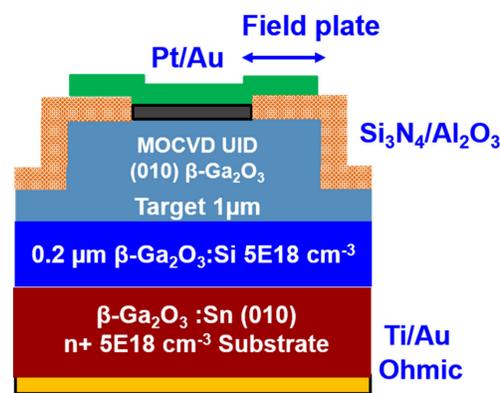
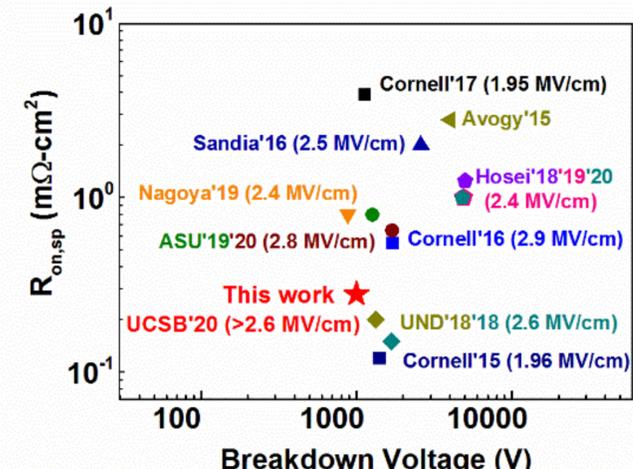
High on/off ratio & low $R_{on} \sim 0.28 \text{ m}\Omega\text{-cm}^2$



Breakdown Voltage $>1000 V$



Comparable with the best GaN-on-GaN p-n diodes with only half of their thickness $\sim 4 \mu\text{m}$



On-going and Future Works

- \rightarrow High-Power $\beta\text{-Ga}_2\text{O}_3$ devices with field management using field plate and guard rings.
- \rightarrow Develop improved device isolation with acceptors to avoid mesa-etch damages.
- \rightarrow Explore high- κ dielectrics to control breakdown.

E. Farzana et al., *IEEE Elec. Dev. Lett.*, pp-1-4 (2020)